

**LIST OF REFERENCES CITED BY APPLICANT**

(Use Several Sheets if Necessary)

11000 U.S. PRO  
09/975390  
10/10/01

DOCKET NO.: 2640/1G822-US1

SERIAL NO: not yet assigned

APPLICANT: Kenneth S. KRAMER, et al.

FILING DATE: Concurrently herewith

CONFIRMATION NO:

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
✓                               ○	1. 2,917,691	12/15/59	DePrisco et al.	318	118	07/10/56
	2. 5,001,649	03/19/91	Lo et al.	364	484	09/16/88
	3. 5,112,300	05/12/92	Ureche	604	22	04/03/90
	4. 5,026,387	06/25/91	Thomas	606	169	03/12/90
	5. 5,180,363	01/19/93	Idemoto et al.	202	32	12/23/91
	6. 5,400,267	03/21/95	Denen et al.	364	552	12/08/92
	7. 5,425,704	06/20/95	Sakurai et al.	604	22	06/09/92
	8. 5,449,370	09/12/95	Vaitekunas	606	169	05/12/93
	9. 5,630,420	05/20/97	Vaitekunas	128	662.03	09/29/95
	10. 5,707,369	01/13/98	Vaitekunas et al.	606	31	04/24/95
	11. 5,879,364	03/09/99	Bromfield et al.	606	169	09/30/97
	12. 5,968,007	10/19/99	Simon et al.	604	22	05/01/97
	13. 6,017,354	01/25/00	Culp et al.	606	170	08/15/96
	14. 6,019,775	02/01/00	Sakurai	606	169	06/23/98
	15. 6,066,135	05/23/00	Honda	606	39	09/22/98
	16. 6,090,123	07/18/00	Culp et al.	606	180	02/12/99

**FOREIGN PATENT DOCUMENTS**

*EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
✓	17. 2000-175926	06/27/00	Japan			Abstract

EXAMINER: Guyen Victor DATE CONSIDERED: 7/8/04

\*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.